

<b>Notice of References Cited</b>	Application/Control No. 10/810,486	Applicant(s)/Patent Under Reexamination FURUSAWA, MITSURU	
	Examiner Michael D. Burkhart	Art Unit 1633	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0003536 A1	01-2005	Furusawa, Mitsuru	435/455
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kokoska, R. et al., "Increased Rates of Genomic Deletions Generated by Mutations in the Yeast Gene Encoding DNA Polymerase delta or by Decreases in the Cellular Levels of DNA Polymerase delta", 2000, Mol. Cell. Biol., Vol. 20: pp. 7490-7504.
	V	
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	X	

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